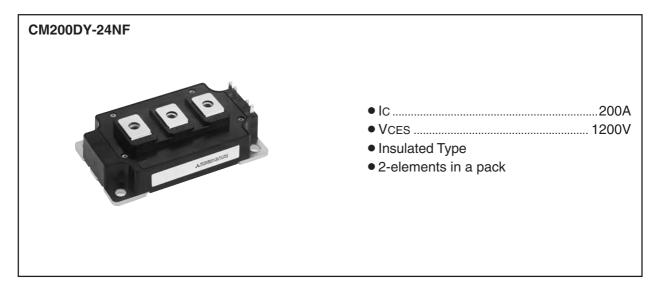
MITSUBISHI IGBT MODULES

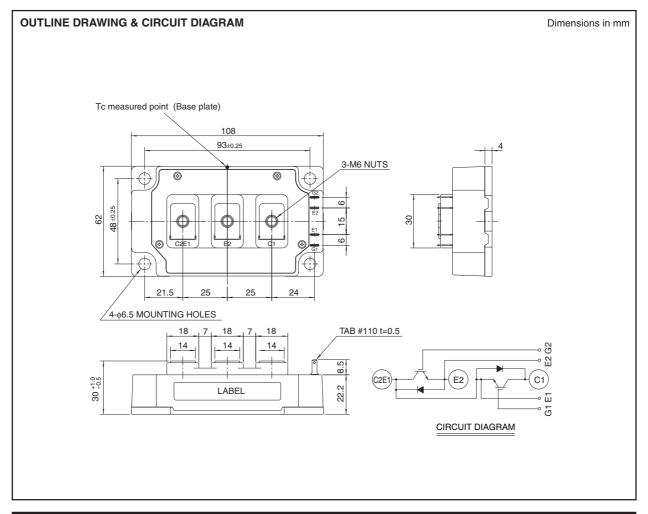
# **CM200DY-24NF**

HIGH POWER SWITCHING USE



## **APPLICATION**

General purpose inverters & Servo controls, etc





# **CM200DY-24NF**

## **HIGH POWER SWITCHING USE**

#### MAXIMUM RATINGS (Tj = 25°C, unless otherwise specified)

Symbol	Parameter	Conditions		Ratings	Unit
VCES	Collector-emitter voltage	G-E Short		1200	V
VGES	Gate-emitter voltage	C-E Short		±20	V
Ic	Collector current	DC, $Tc' = 112^{\circ}C^{*3}$		200	Α
Ісм	Collector current	Pulse	(Note 2)	400	Α
IE (Note 1)	Emitter current			200	Α
IEM (Note 1)	Emilier current	Pulse	(Note 2)	400	Α
PC (Note 3)	Maximum collector dissipation	Tc = 25°C		1130	W
Tj	Junction temperature			-40 ~ +150	°C
Tstg	Storage temperature			<b>−</b> 40 ~ +125	°C
Viso	Isolation voltage	Terminals to base plate, f = 60Hz, AC 1 minut	е	2500	Vrms
_	Torque etropath	Main terminals M6 screw		3.5 ~ 4.5	N•m
_	Torque strength	Mounting M6 screw		3.5 ~ 4.5	N•m
_	Weight	Typical value		400	g

## ELECTRICAL CHARACTERISTICS (Tj = 25°C, unless otherwise specified)

0	Dovometer	Test conditions		Limits			
Symbol	Parameter			Min.	Тур.	Max.	Unit
ICES	Collector cutoff current	VCE = VCES, VGE = 0V		_	_	1	mA
VGE(th)	Gate-emitter threshold voltage	IC = 20mA, VCE = 10V		6	7	8	V
IGES	Gate leakage current	±VGE = VGES, VCE = 0V		_	_	0.5	μΑ
VCE(sat)	Collector-emitter saturation voltage	IC = 200A, VGE = 15V	Tj = 25°C	_	1.8	2.5	V
			Tj = 125°C	_	2.0	_	
Cies	Input capacitance	VCE = 10V VGE = 0V		_	_	47	nF
Coes	Output capacitance			_	_	4	nF
Cres	Reverse transfer capacitance			_	_	0.9	nF
QG	Total gate charge	Vcc = 600V, Ic = 200A, VGE = 15V		_	1350	_	nC
td(on)	Turn-on delay time	VCC = 600V, IC = 200A $VGE = \pm 15V$ $RG = 1.6\Omega, Inductive load IE = 200A$		_	_	500	ns
tr	Turn-on rise time			_	_	150	ns
td(off)	Turn-off delay time			_	_	600	ns
tf	Turn-off fall time			_	_	350	ns
trr (Note 1)	Reverse recovery time			_	_	250	ns
Qrr (Note 1)	Reverse recovery charge			_	7.5	_	μC
VEC(Note 1)	Emitter-collector voltage	IE = 200A, VGE = 0V		_	_	3.2	V
Rth(j-c)Q	Thermal resistance*1	IGBT part (1/2 module)		_	_	0.11	K/W
Rth(j-c)R	Thermal resistance	FWDi part (1/2 module)		_	_	0.19	K/W
Rth(c-f)	Contact thermal resistance	Case to heat sink, Thermal compound Applied <sup>*2</sup> (1/2 module)		_	0.04	_	K/W
Rth(j-c')Q	Thermal resistance	Case temperature measured point is just under the chips		_	_	0.066*3	K/W
Rg	External gate resistance			1.6	_	16	Ω



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<sup>\*1 :</sup> Case temperature (Tc) measured point is shown in page OUTLINE DRAWING. \*2 : Typical value is measured by using thermally conductive grease of  $\lambda$  = 0.9[W/(m • K)]. \*3 : Case temperature (Tc') measured point is just under the chips.

If you use this value, Rth(f-a) should be measured just under the chips.

Note 1. IE, VEC, trr & Qrr represent characteristics of the anti-parallel, emitter-collector free-wheel diode (FWDi).

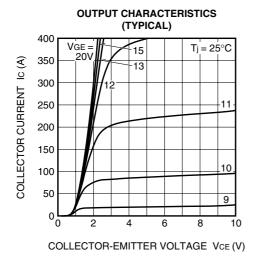
2. Pulse width and repetition rate should be such that the device junction temperature (Tj) does not exceed Tjmax rating.

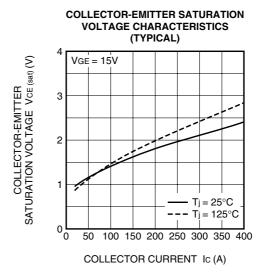
3. Junction temperature (Tj) should not increase beyond 150°C.

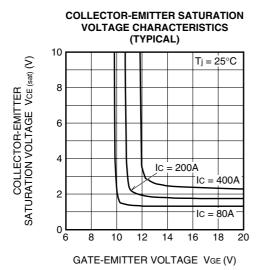
## CM200DY-24NF

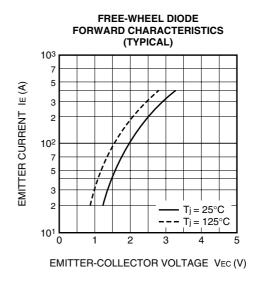
#### HIGH POWER SWITCHING USE

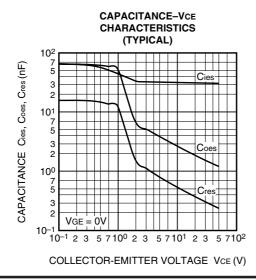
#### **PERFORMANCE CURVES**

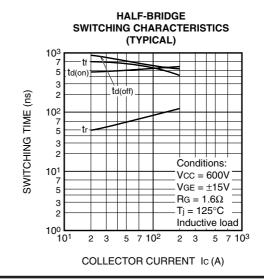












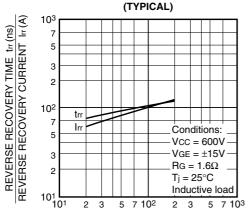


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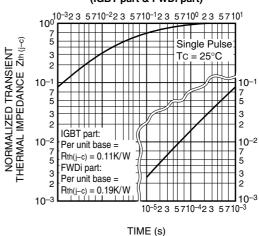
## **HIGH POWER SWITCHING USE**

#### REVERSE RECOVERY CHARACTERISTICS OF FREE-WHEEL DIODE (TYPICAL)

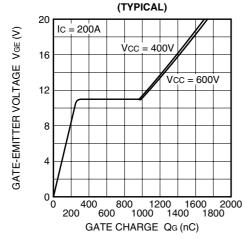


#### EMITTER CURRENT IE (A)

#### TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (IGBT part & FWDi part)



# GATE CHARGE CHARACTERISTICS





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